

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/749,654	STASZEWSKI ET AL.	
Examiner	Art Unit	
Erin M. File	2611	

	SEARCHED				
Class	Subclass	Date	Examiner		
375	285	2/8/2007	EMF		
455	296-312	2/8/2007	EMF		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	2/8/2007	EMF .		
PALM INVENTORSHIP	2/8/2007	EMF		
PLUS Search	2/8/2007	EMF		
Google Patent Search	2/8/2007	EMF .		
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